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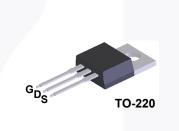
## FQP55N10 N-Channel QFET<sup>®</sup> MOSFET 100 V, 55 A, 26 mΩ

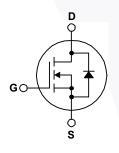
## Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

## Features

- 55 A, 100 V,  $R_{DS(on)}$  = 26 m $\Omega$  (Max.) @  $V_{GS}$  = 10 V,  $I_{D}$  = 27.5 A
- Low Gate Charge (Typ. 75 nC)
- Low Crss (Typ. 130 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating





### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

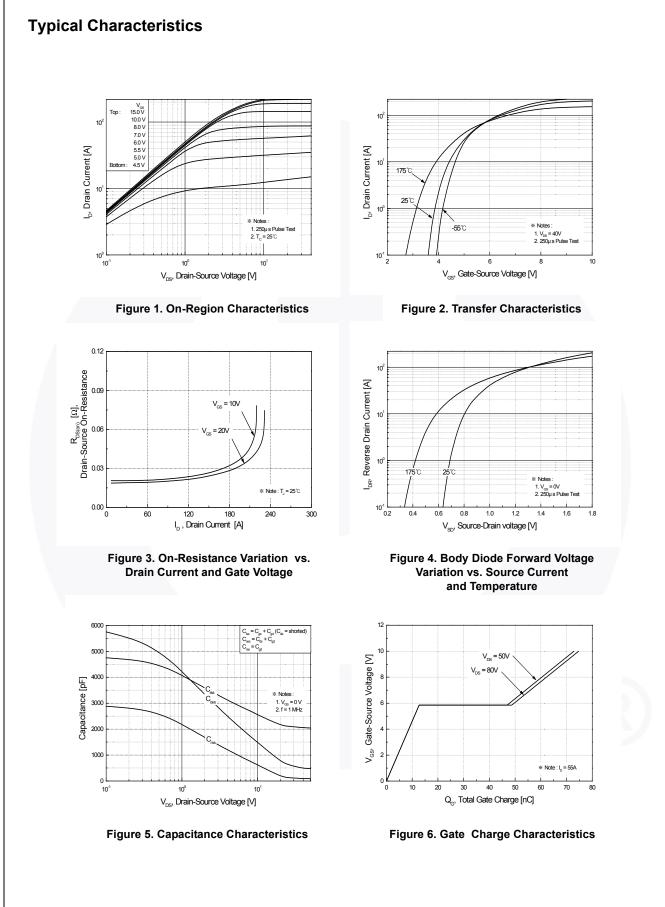
Symbol	Parameter		FQP55N10	Unit
V <sub>DSS</sub>	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}C$ )		55	A
	- Continuous (T <sub>C</sub> = 100°C)		38.9	A
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	220	A
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1100	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	55	A
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3		6.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)		155	W
- Derate above 25°C		1.03	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	°C
TI	Maximum Lead Temperature for Soldering,		300	°C
'L	1/8" from Case for 5 seconds	500	C	

## **Thermal Characteristics**

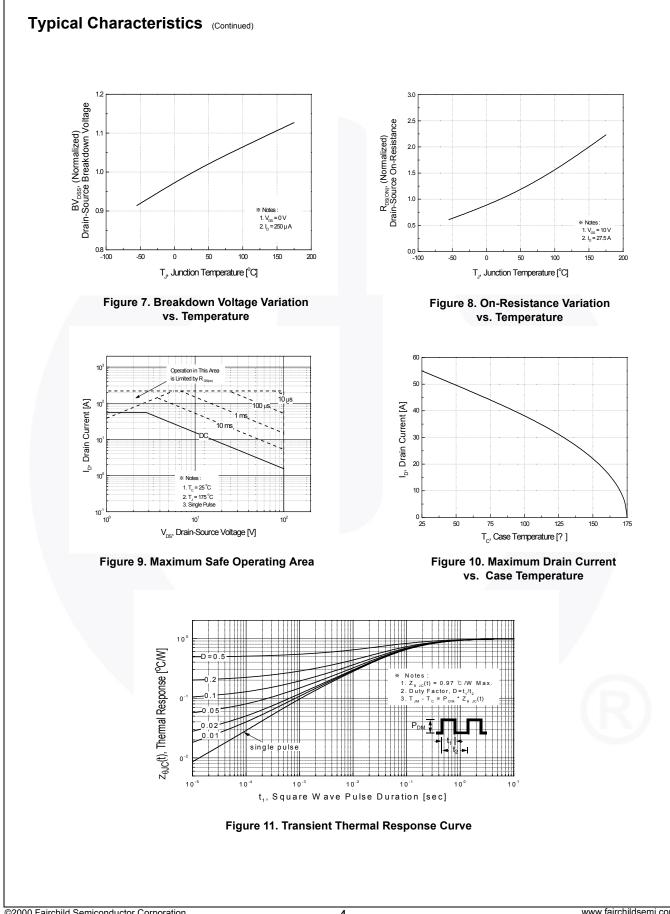
Symbol	Parameter	FQP55N10	Unit	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case, Max.	0.97	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W	

November 2013

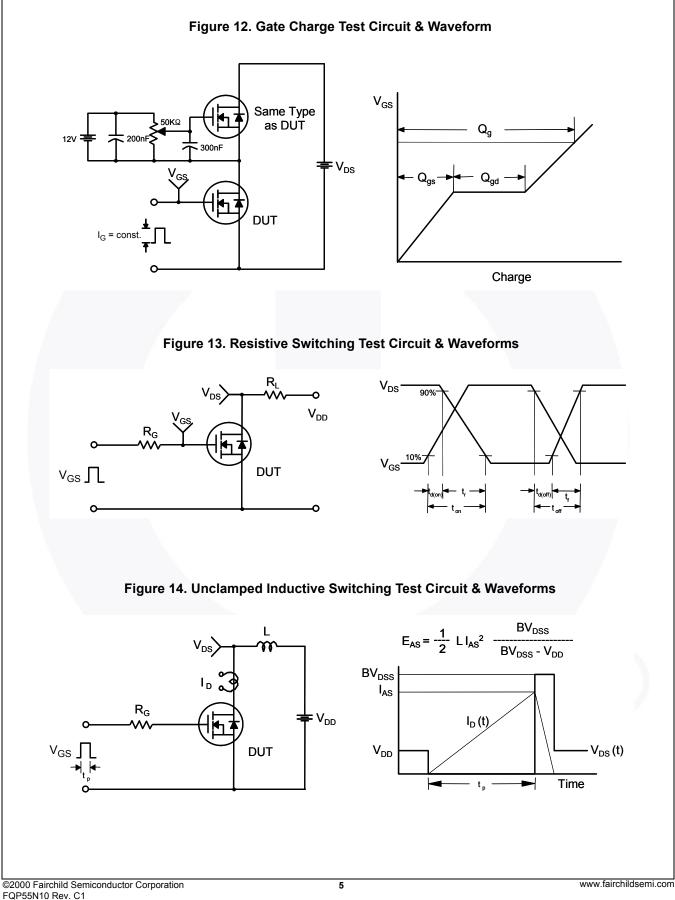
Part Number		Top Mark	Package	Packing Method	Reel Size	Ta	pe Widt	h Q	uantity	
FQP	FQP55N10 FQP55N10		TO-220				N/A		50 units	
lectri	cal Chara	acteristics T <sub>c</sub> = 25	°C unless other	vise noted.						
Symbol		Parameter		Test Conditions		Min	Тур	Мах	Unit	
Off Cha	aracteristic	`e								
BV <sub>DSS</sub>		ce Breakdown Voltage	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA		100			V	
∆BV <sub>DSS</sub>	Breakdown	Voltage Temperature		μA, Referenced to 25	°C		0.1		V/°C	
$\Delta T_J$	Coefficient	nt			0		0.1		V/ C	
I <sub>DSS</sub>	Zero Gate V	Zero Gate Voltage Drain Current		0 V, V <sub>GS</sub> = 0 V				1	μA	
				V, T <sub>C</sub> = 150°C				10	μA	
GSSF		Leakage Current, Forward		$V, V_{DS} = 0 V$				100	nA	
GSSR	Gate-Body	Leakage Current, Reverse	$V_{GS} = -2$	5 V, V <sub>DS</sub> = 0 V				-100	nA	
On Cha	aracteristic	s								
V <sub>GS(th)</sub>	Gate Thres	hold Voltage	$V_{DS} = V_{C}$	<sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0		4.0	V	
R <sub>DS(on)</sub>	Static Drain On-Resistar		V <sub>GS</sub> = 10	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 27.5 \text{ A}$			0.021	0.026	Ω	
9 <sub>FS</sub>		ansconductance	V <sub>DS</sub> = 40	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 27.5 A			38		S	
Dynam C <sub>iss</sub> C <sub>oss</sub>	ic Charact Input Capac Output Cap	citance		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz			2100 640	2730 830	pF pF	
C <sub>rss</sub>	Reverse Tra	ansfer Capacitance					130	170	pF	
	ing Charos					1				
	ing Charac Turn-On De						25	60	ns	
t <sub>d(on)</sub> t <sub>r</sub>	Turn-On Ris			) V, I <sub>D</sub> = 55 A,			250	510	ns	
r t <sub>d(off)</sub>	Turn-Off De		R <sub>G</sub> = 25	R <sub>G</sub> = 25 Ω (Note 4)			110	230	ns	
f	Turn-Off Fa	,	_				140	290	ns	
Q <sub>g</sub>	Total Gate C		$V_{-} = 80$	$V_{DS} = 80 \text{ V}, I_D = 55 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4)			75	98	nC	
Q <sub>gs</sub>	Gate-Sourc						13		nC	
Q <sub>gd</sub>	Gate-Drain	0	- GS . C				36		nC	
							I			
		de Characteristics		-					1	
l <sub>S</sub>		Continuous Drain-Source D						55	Α	
SM		Pulsed Drain-Source Diode						220	A	
V <sub>SD</sub>		e Diode Forward Voltage	00	$V_{GS} = 0 V, I_S = 55 A$				1.5	V	
		covery Time		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 55 A, dI <sub>F</sub> / dt = 100 A/μs			100		ns	
Q <sub>rr</sub>	Reverse Re	covery Charge	u <sub>F</sub> / ul =	100 Ανμ5			380		nC	



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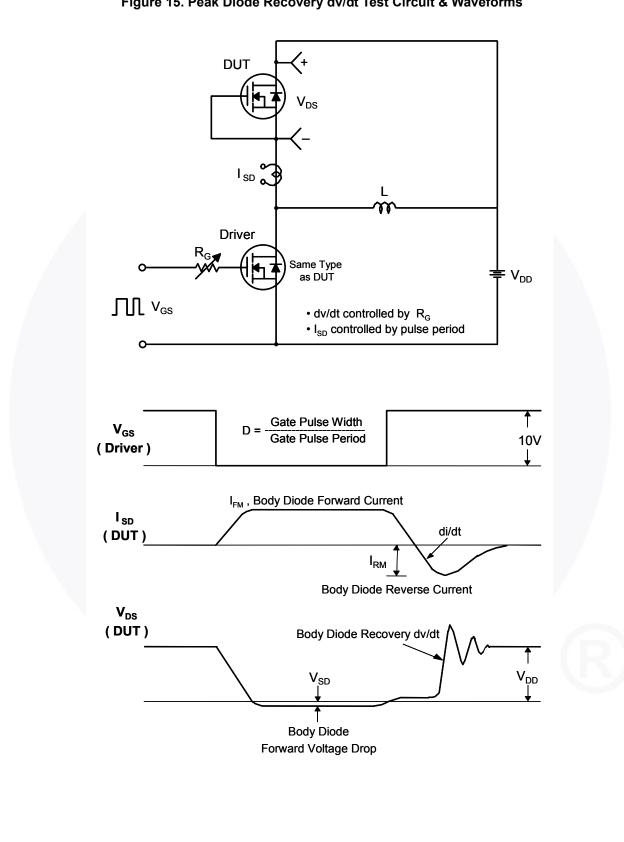
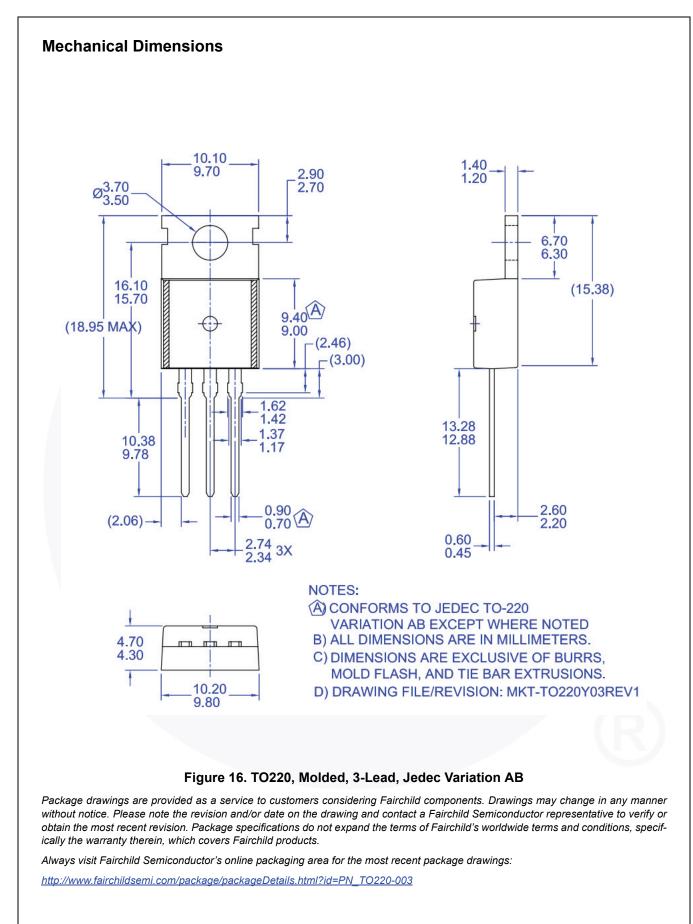


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





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